

P-Channel 30-V (D-S) MOSFET

Description

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low rDS(on) and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

Features

- Low rDS(on) provides higher efficiency and extends battery life
- Low thermal impedance copper lead frame TSOP-6 saves board space
- · RoHS compliant package

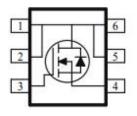
Packing & Order Information

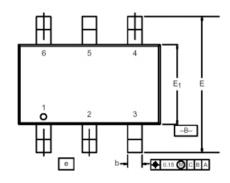
3,000/Reel

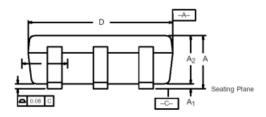


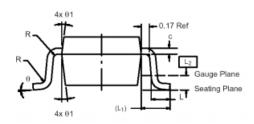
RoHS COMPLIANT

Graphic symbol









	МІІ	LIMET	ERS	INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	_	1.10	0.036	-	0.043	
Α1	0.01	_	0.10	0.0004	-	0.004	
A ₂	0.84	_	1.00	0.033	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013 0.018		
С	0.10	0.15	0.20	0.004	0.006 0.00		
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	2.70	2.85	2.98	0.106	0.112	0.117	
E ₁	1.55	1.65	1.70	0.061	0.065	0.067	
е	1.00 BSC			0.0394 BSC			
L	0.35	-	0.50	0.014 - 0.020			
L ₁	0.60 Ref			0.024 Ref			
L ₂	0.25 BSC			0.010 BSC			
R	0.10	_	_	0.004	-	_	
θ	0°	4°	8°	0°	4°	8°	
θ1	7° Nom 7° Nom						



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Absolute Maximum Ratings (Tc=25°C unless otherwise specified)						
Symbol	Parameter	Value	Unit			
V_{DS}	Drain-Source Voltage	30	V			
V _{GS}	Gate-Source Voltage	±20	V			
1	Continuous Drain Current ^a (T _A =25°C)	-2.5	А			
I _D	Continuous Drain Current ^a (T _A =70°C)	-1.9	Α			
I _{DM}	Pulsed Drain Current ^b	-10	А			
Is	Continuous Source Current (Diode Conduction) ^a	±1.6	А			
P _D	Power Dissipation ^a (T _A =25°C)	1.15	W			
	Power Dissipation ^a (T _A =70°C)	0.7	W			
T _J /T _{STG}	Operating Junction and Storage Temperature	-55 to +150	°C			

Thermal Resistance Ratings						
Symbol	Parameter	Тур	Max	Units		
R _{THJA}	Maximum Junction-to-Ambient ^a (t <= 10 sec)	93	110	°C/W		
	Maximum Junction-to-Ambient ^a (Steady-State)	130	150	C/VV		

Notes:

- a. Surface Mounted on 1" x 1" FR4 Board.
- b. Pulse width limited by maximum junction temperature

Static						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
$V_{GS(th)}$	Gate-Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = -250\mu A$	-1			
I _{GSS}	Gate-Body Leakage	V_{DS} =0 V , V_{GS} = ± 20 V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}$, $V_{GS} = 0 \text{ V}$ $V_{DS} = -24 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_{J} = 55^{\circ}\text{C}$			-1 -10	uA
I _{D(on)}	On-State Drain Current ^A	$V_{DS} = -5 \text{ V}, V_{GS} = -10 \text{ V}$	-3			Α
I _{DS(on)}	Drain-Source On-Resistance ^A	$V_{GS} = -10 \text{ V}$, $I_D = -2.5 \text{ A}$ $V_{GS} = -4.5 \text{ V}$, $I_D = -1.9 \text{ A}$			0.13 0.19	Ω
g _{fs}	Forward Tranconductance ^A	$V_{DS} = -5 \text{ V}$, $I_{D} = -2.5 \text{ A}$		3		S
V _{SD}	Diode Forward Voltage	I _S = -1.6 A , V _{GS} = 0 V		-0.70		V

Dynamic ^b							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
Q_g	Total Gate Charge	$V_{DS} = -5 \text{ V}, I_{D} = -2.5 \text{ A},$ $V_{GS} = -4.5 \text{ V}$		6.0		nC	
Q_gs	Gate-Source Charge			0.8		nC	
Q_{gd}	Gate-Drain Charge			1.3		nC	



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Dynamic ^b							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -5 \text{ V}$, $R_L = 5 \text{ OHM}$, $V_{GEN} = -4.5 \text{ V}$, $R_G = 5 \text{ OHM}$,		6.5		ns	
t _r	Rise Time			20		ns	
t _{d(off)}	Turn-Off Delay Time			31		ns	
tf	Fall Time			21		ns	
C _{ISS}	Input Capacitance	P-Channel $V_{DS} = -15 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1.0 \text{MHz}$		451		pF	
C _{oss}	Output Capacitance			130		pF	
C _{RSS}	Reverse Transfer Capacitance			33		pF	

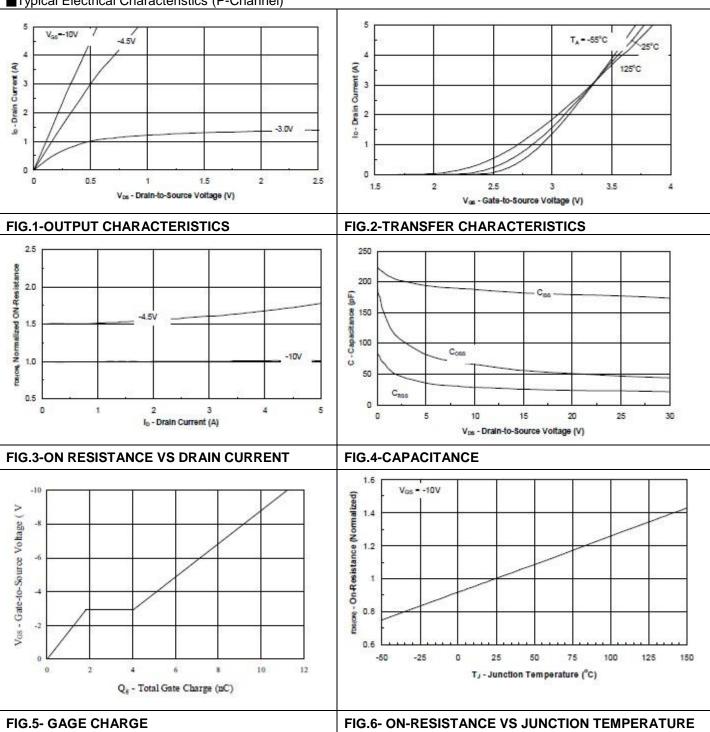
Notes:

- a. Pulse test: PW <= 300us duty cycle <= 2%.
- b. Guaranteed by design, not subject to production testing.



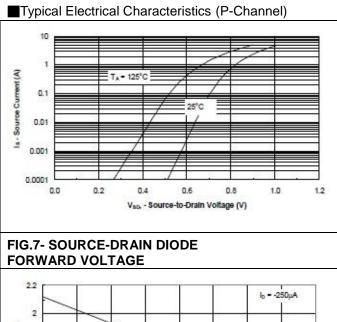
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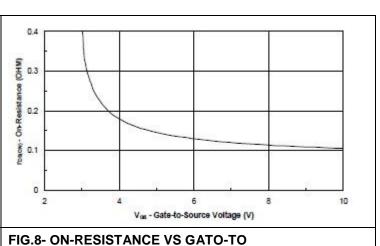
■Typical Electrical Characteristics (P-Channel)





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FORWARD VOLTAGE

22

1.5

1.6

1.7

1.7 Temperature (°C)

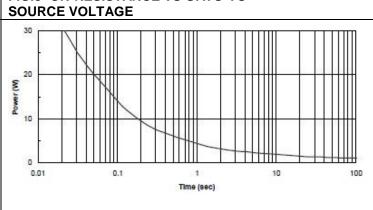


FIG.9-THRESHOLD VOLTAGE

FIG.10-SINGLE PULSE POWER

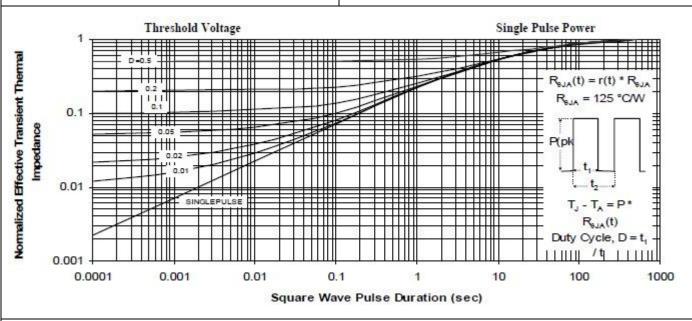


FIG.11-NORMALIZED THERMAL TRANSIENT JUNCTION TO AMBIENT



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